

ABSTRACT OF THE DISCLOSURE

The semiconductor device includes a first chip having an electrically rewritable nonvolatile memory and a second chip having memories including a redundant circuit for repair.

- 5 The first and second chips are provided on a substrate. Information required for utilizing the redundant circuit in place of a faulty portion in the memories on the second chip is stored in the nonvolatile memory on the first chip. When a faulty portion is detected in the memories on the
- 10 second chip, the redundant circuit is utilized in place of the faulty portion based on the information stored in the nonvolatile memory.

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